Se	arch Notes
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/659,384	BAE ET AL.
Examiner	Art Unit

Hoai v. Pham

2814

SEARCHED					
Class	Subclass	Date	Examiner		
257	336	6/22/2005	НР		
257	337	6/22/2005	HP		
257	338	6/22/2005	НР		
257	369	6/22/2005	НР		
257	388	6/22/2005	HP		
257	407	6/22/2005	HP		
up date	search	12/1/2005	HP		
up date	search	4/12/2006	НР		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
East search	6/22/2005	HP
East search (see printout history)	12/1/2005	НР
East search (see printout history)	4/12/2006	НР